•	Searcn	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/770,473	HSU, HUL-CHUN
Examiner	Art Unit
David E. Bochna	3679

SEARCHED				
Class	Subclass	Date	Examiner	
-				

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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DATE 6/29/2006	EXMR DB
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